

Fraunhofer Institute for Integrated Circuits IIS Design Automation Division EAS

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Recommendation letter for Daniel Dobiński

Fraunhofer IIS, Division EAS | Zeunerstraße 38 | 01069 Dresden | Germany

Dear Sir or Madam,

To whom it may concern

Daniel Dobiński currently spends a traineeship at our institute, the full stay will be from Oct 1 to Dec 31, 2015. His work here focuses on the reliability of microelectronic devices in various advanced sub-micrometre technologies, especially on the degradation of MOSFET devices in integrated circuits for automotive or high-voltage applications.

I got to know Daniel Dobiński as an open-minded and highly interested person. His contributions to the working projects are particularly helpful and comprise the analysis of experimental data, the degradation simulation with numerical tools and the comparison to theoretical ageing models.

I support his decision to apply within the Erasmus Mundus programmes and recommend him without any reservation.

Kay-Uwe Gierring

Dr. Kay-Uwe Giering

Roland Jancke

Group leader "Reliability and Test"